



## ResMap 273-Solar

Based on the technology of the Model 178-Solar, the ResMap Model 273-Solar is the first 210mm table top automatic four point probe. The Model 273-Solar extends the capability and performance of previous ResMap models to meet the needs of the 210mm solar process development and solar conductive film characterization. The small footprint and rugged design have the same accuracy and repeatability which define ResMap metrology.

<b>Wafer handling:</b>	Manual load
<b>Wafer Size:</b>	125mm x 125mm 156mm x 156mm 210mm x 210mm (maximum) 2" – 12" diameter
<b>Typical Measurement Time:</b>	1 second per site
<b>Maximum Throughput:</b>	1 minute per wafer (49 sites)
<b>Measurement Range:</b>	2 mΩ/□ - 5 MΩ/□ (can be optimized to 1 mΩ/□)
<b>Repeatability (1σ, typical):</b>	≤ ±0.02% (static or Rs pack); ≤ ±0.1% (dynamic nearby spots)
<b>Accuracy:</b>	≤ ±0.5% using NIST traceable ResCal standards
<b>Minimum Edge Exclusion:</b>	1.5mm (center of probe to edge of film)

<b>Computer System:</b>	Pentium class; Windows XP Home (display not included)
<b>SECS-II Option:</b>	Available
<b>Mapping Patterns:</b>	Square or rectangular map (choose inside edge exclusion); line scan (diameter, radius or any point to point along diameter, minimum step 0.1mm); user defined (template)
<b>Plots:</b>	Contour (spacing choice, 1/3σ, fixed and auto %), 3D, line, data map, histogram, data sequence, radial and angular distributions; various modes of trend charts available
<b>Data:</b>	All ResMap data files may be ported to programs such as Excel® for further analysis.

<b>Facilities</b>	
<b>House Vacuum :</b>	Vacuum is not required.
<b>AC Power:</b>	100V to 240V < 10 KVA
<b>Size (inches): width x depth x height</b>	15" w x 18"d x 10"h; tabletop (table not included)